

<b>Notice of References Cited</b>	Application/Control No. 10/783,651	Applicant(s)/Patent Under Reexamination SMALL ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	D	US-			
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	F	US-			
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*	A	US-5872043	02-1999	Chen	438/424
*	B	US-5976979	11-1999	Chen	438/691
	C	US-6100198	08-2000	Grieger et al.	438/692
*	D	US-6124210 MA	09-2000	Chino et al.	438/706
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09/783,069

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